# MOSFET – Power, Single N-Channel

40 V, 0.67 mΩ, 420 A

### NTMTSOD7N04C

#### **Features**

- Small Footprint (8x8 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- Power 88 Package, Industry Standard
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Voltage	Э		$V_{GS}$	±20	٧
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	420	Α
Current R <sub>θJC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 100°C		297	
Power Dissipation	State	T <sub>C</sub> = 25°C	$P_{D}$	205	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		103	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	65	Α
Current R <sub>θJA</sub> (Notes 1, 2, 3)	Steady	T <sub>A</sub> = 100°C		46	
Power Dissipation	State	T <sub>A</sub> = 25°C	$P_{D}$	4.9	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C		2.5	
Pulsed Drain Current	T <sub>A</sub> = 25	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C	
Source Current (Body Diode)			Is	171	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 40 A)		E <sub>AS</sub>	1446	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.73	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	30.4	

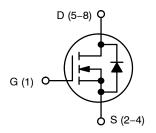
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	$0.67~\text{m}\Omega$ @ $10~\text{V}$	420 A



**N-CHANNEL MOSFET** 



DFNW8 TX SUFFIX CASE 507AP

#### MARKING DIAGRAM



XXX = Device Code

(8 A-N characters max)

A = Assembly Location

WL = 2-digit Wafer Lot Code

Y = Year Code

WW = Work Week Code

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

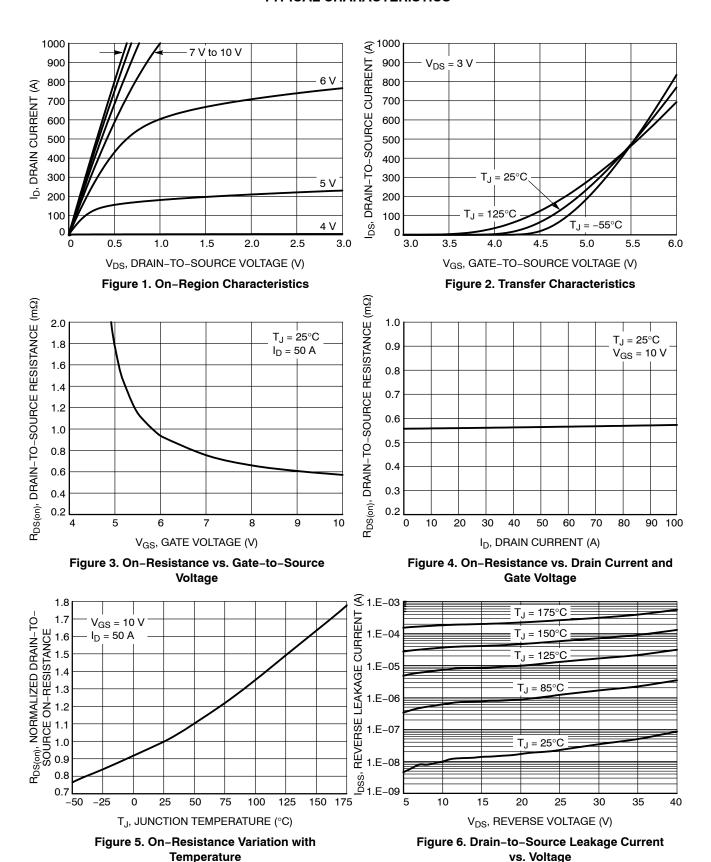
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				20		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>					10	
		V <sub>DS</sub> = 40 V	T <sub>J</sub> = 125°C			250	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μA	2.0		4.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-8.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		0.57	0.67	mΩ
Forward Transconductance	9 <sub>F</sub> s	V <sub>DS</sub> =5 V, I <sub>D</sub>	= 50 A		200		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE				•		
Input Capacitance	C <sub>ISS</sub>				9230		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V			4730		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				126		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 20 V; I <sub>D</sub> = 50 A			140		
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 20 V; I <sub>D</sub> = 50 A			22.7		nC
Gate-to-Source Charge	Q <sub>GS</sub>				37		
Gate-to-Drain Charge	$Q_GD$				28.3		
Plateau Voltage	$V_{GP}$				4.28		V
SWITCHING CHARACTERISTICS (Note	5)						•
Turn-On Delay Time	t <sub>d(ON)</sub>				28.9		
Rise Time	t <sub>r</sub>	Vce = 10 V. Vne	e = 20 V.		18.1		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 20 V, $I_{D}$ = 50 A, $R_{G}$ = 6 $\Omega$			61.0		- ns
Fall Time	t <sub>f</sub>				20.4		
DRAIN-SOURCE DIODE CHARACTERIS	STICS				1		
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 50 A	T <sub>J</sub> = 25°C		0.77	1.2	
			T <sub>J</sub> = 125°C		0.65		<b>-</b>
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 50 A			83		
Charge Time	t <sub>a</sub>				58		ns
Discharge Time	t <sub>b</sub>				25		1
Reverse Recovery Charge	Q <sub>RR</sub>				191		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



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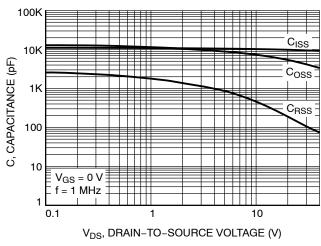


Figure 7. Capacitance Variation

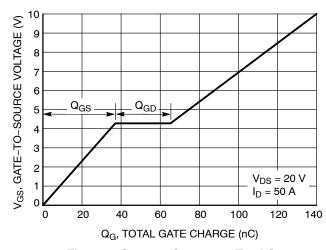


Figure 8. Gate-to-Source vs. Total Gate Charge

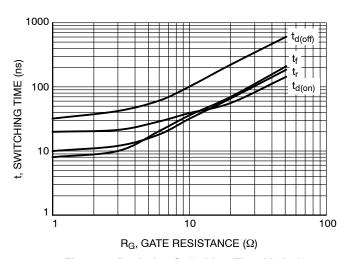


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

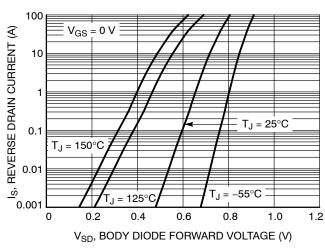


Figure 10. Diode Forward Voltage vs. Current

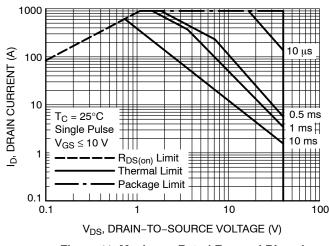


Figure 11. Maximum Rated Forward Biased Safe Operating Area

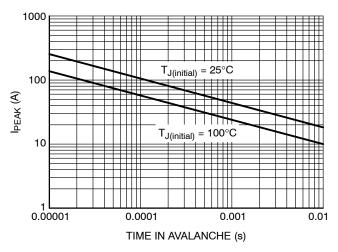


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

#### **TYPICAL CHARACTERISTICS**

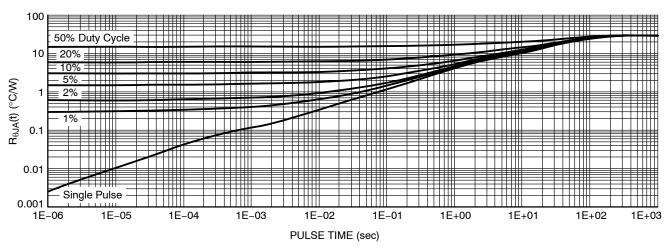


Figure 13. Thermal Characteristics –  $R_{\theta JA}(t)$  (°C/W)

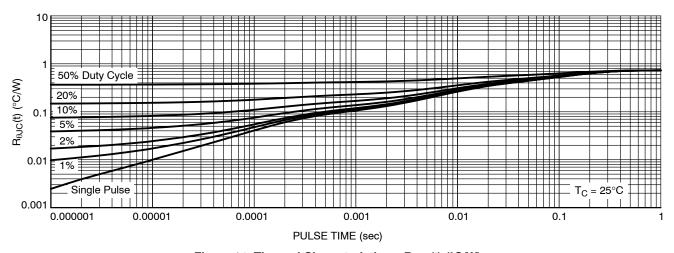
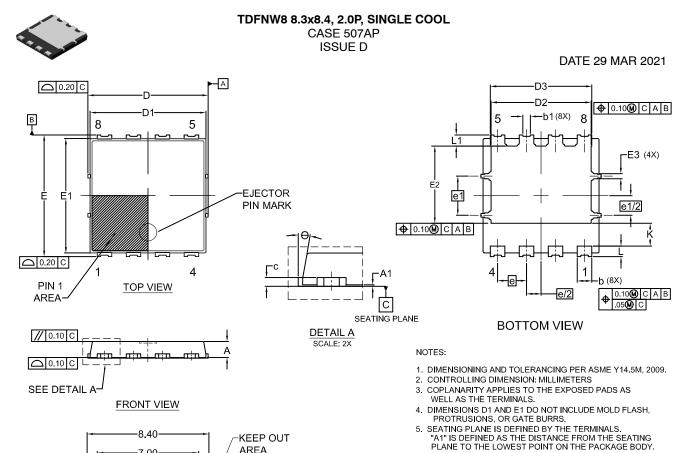


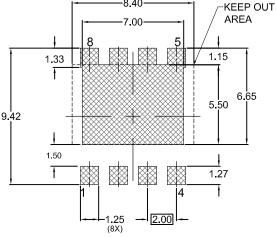
Figure 14. Thermal Characteristics –  $R_{\theta JC}(t)$  (°C/W)

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NTMTS0D7N04CTXG	0D7N04C	POWER 88 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

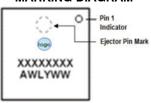




#### RECOMMENDED LAND PATTERN\*

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

# GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code
A = Assembly Location
WL = Wafer Lot Code
Y = Year Code
WW = Work Week Code

<sup>\*</sup>This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.

DIM	MILLIMETERS				
DIW	MIN.	MAX.			
Α	1.00	1.10	1.20		
A1	0.00	-	0.05		
b	0.90	1.00	1.10		
b1	0.35	0.45	0.55		
C	0.23	0.28	0.33		
О	8.20	8.30	8.40		
D1	7.90	8.00	8.10		
D2	6.80	6.90	7.00		
D3	6.90	7.00	7.10		
Е	8.30	8.40	8.50		
E1	7.80	7.90	8.00		
E2	5.24	5.34	5.44		
E3	0.25	0.35	0.45		
е		2.00 BS	С		
e/2	1.00 BSC				
e1	2.70 BSC				
e1/2	1.35 BSC				
K	1.50	1.57	1.70		
L	0.64	0.74	0.84		
L1	0.67	0.77	0.87		
Ф	0°		12°		

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